## Search Notes



| Αp | plica | tion | /Contro | l No |
|----|-------|------|---------|------|
|    |       |      |         |      |

10731899

Applicant(s)/Patent Under Reexamination

JONES ET AL.

Art Unit

Examiner Chen, Qing

2191

## SEARCHED

| Class | Subclass    | Date      | Examiner |
|-------|-------------|-----------|----------|
| 717   | 168-178     | 6/11/2010 | /QC/     |
| 715   | 705,708-715 | 6/11/2010 | /QC/     |
| 434   | 322,365     | 6/11/2010 | /QC/     |

## SEARCH NOTES

| <del></del>  |           |          |  |  |  |
|--|-----------|----------|--|--|--|
| Search Notes   | Date      | Examiner |  |  |  |
| Updated EAST Search (US-PGPUB; USPAT; USOCR; EPO; JPO;           | 6/11/2010 | /QC/     |  |  |  |
| DERWENT; IBM_TDB) See Search History Printout                    |           |          |  |  |  |
| 717/168-178; 715/705,708-715; 434/322,365 (limited class search) | 6/11/2010 | /QC/     |  |  |  |
| Updated EAST Inventor Name Search and Assignee Search (US-PGPUB; | 6/11/2010 | /QC/     |  |  |  |
| USPAT) See Search History Printout                               |           |          |  |  |  |
| NPL Search (ACM) See Printout                                    | 8/9/2008  | /QC/     |  |  |  |
| Updated PALM Inventor Name Search                                | 8/9/2008  | /QC/     |  |  |  |
| Consulted SPE Wei Zhen (AU 2191)                                 | 8/7/2008  | /QC/     |  |  |  |

## INTERFERENCE SEARCH

| INTERI ERENOE SEAROTI |             |           |          |  |  |  |
|-----------------------|-------------|-----------|----------|--|--|--|
| Class                 | Subclass    | Date      | Examiner |  |  |  |
| 717                   | 168-178     | 6/11/2010 | /QC/     |  |  |  |
| 715                   | 705,708-715 | 6/11/2010 | /QC/     |  |  |  |
| 434                   | 322,365     | 6/11/2010 | /QC/     |  |  |  |

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